Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | WILSON, ANDREW D. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0135824	07-2004	Fitzmaurice, George William	345/856
*	В	US-5,424,823	06-1995	Nettles et al.	356/5.01
*	С	US-5,479,528	12-1995	Speeter, Thomas H.	382/115
*	D	US-6,674,900	01-2004	Ma et al.	382/176
*	E	US-2003/0235341	12-2003	Gokturk et al.	382/243
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	U\$-		\	

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S	· .				
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
*	υ	Xu et al. ("A Robust Close-range photogrammetric system for industrial metrology," 7th Int'l Conf. on Control, Automation, Robotics and Vision, Dec.2002, pp. 114-119)		
*	v	Tanaka et al. ("Development of a video-rate range finder using dynamic threshold method for characteristic point detection," Int'l Conf. on Advanced Intelligent Mechatronics, 19-23 September 1999, pp. 932-937)		
	w			
	x			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.